



January 2001

Si4466DY

Sigle N-Channel 2.5V Specified PowerTrench® MOSFET

General Description

This N-Channel 2.5V specified MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

Applications

- DC/DC converter
- Load switch
- Battery protection

Features

- 15 A, 20 V. $R_{DS(on)} = 0.0075 \Omega @ V_{GS} = 4.5 V$ $R_{DS(on)} = 0.010 \Omega @ V_{GS} = 2.5 V.$
- Low gate charge (47nC typical).
- Fast switching speed.

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High performance trench technology for extremely low R_{DS(ON)}.

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• High power and current handling capability.



Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		20	V
V _{GSS}	Gate-Source Voltage		±12	V
ID	Drain Current - Continuous	(Note 1a)	15	A
	- Pulsed		50	C.C.C
P _D	Power Dissipation for Single Operation	(Note 1a)	2.5	W
		(Note 1b)	1.2	
		(Note 1c)	1	
T _J , T _{stg}	Operating and Storage Junction Temperatur	re Range	-55 to +150	۰C

Thermal Characteristics

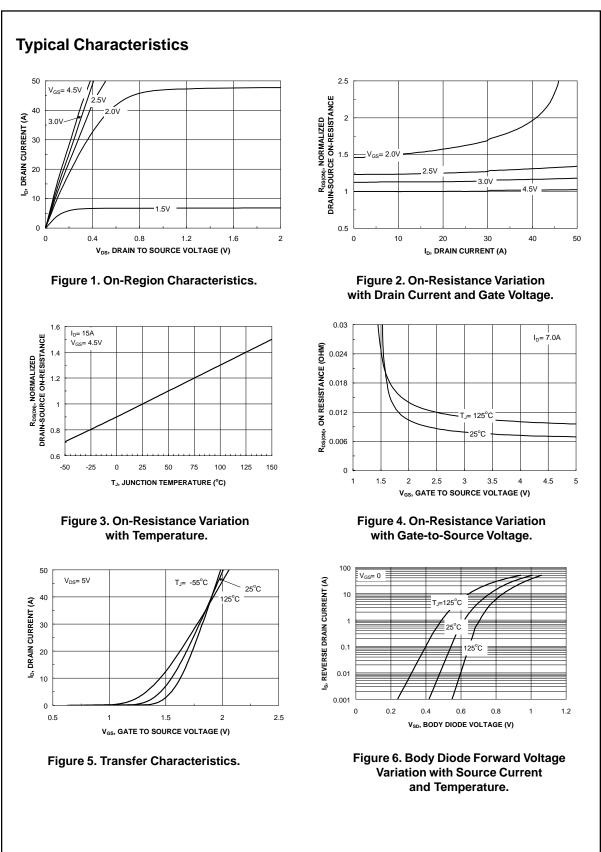
R _{θJA}	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
R _{θJC}	Thermal Resistance, Junction-to-Case	(Note 1)	25	∘C/W

Package Outlines and Ordering Information

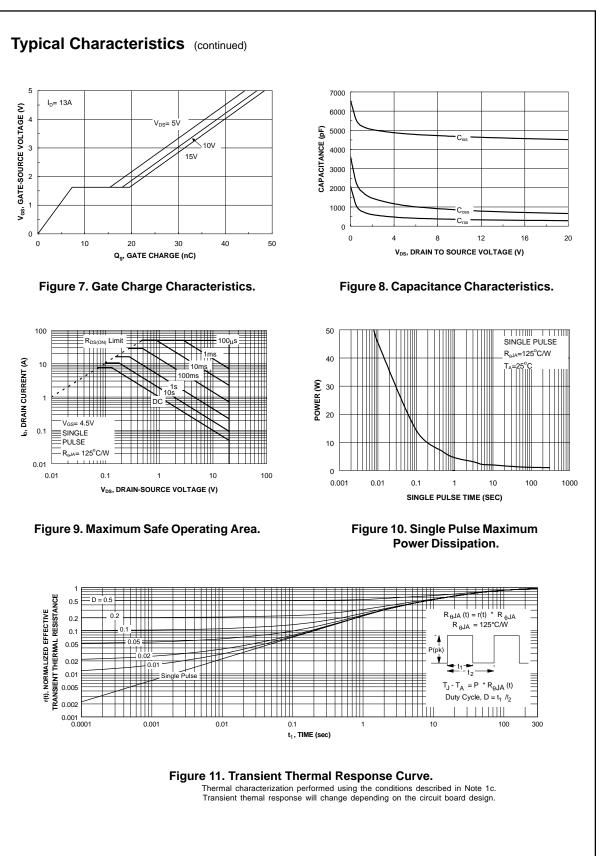
	Device Marking	Device	Reel Size	Tape Width	Quantity
_	4466	Si4466DY	13"	12mm	2500 units

cteristics rain-Source Breakdown Voltage reakdown Voltage Temperature coefficient ero Gate Voltage Drain Current	V_{GS} = 0 V, I_D = 250 µA I_D = 250µA, Referenced to 25°C	20			
rain-Source Breakdown Voltage reakdown Voltage Temperature coefficient		20			
coefficient	$I_D = 250 \mu A$, Referenced to $25^{\circ}C$				V
ero Gate Voltage Drain Current			29		mV/°C
-	$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}$			1	μΑ
ate-Body Leakage, Forward	$V_{GS} = 12 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
ate-Body Leakage, Reverse	$V_{GS} = -12 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
teristics (Note 2)					
	$V_{DS} = V_{GS}$, $I_{D} = 250 \ \mu A$	0.4	0.9	1.5	V
ate Threshold Voltage	$I_D = 250\mu$ A, Referenced to 25°C		-4		mV/°C
tatic Drain-Source n-Resistance	$V_{GS} = 4.5 V, I_D = 15 A$ $V_{GS} = 4.5 V, I_D = 15 A,$ $T_J=125^{\circ}C$ $V_{GS} = 2.5 V, I_D = 12 A$		0.006 0.009 0.008	0.0075 0.0130 0.0100	Ω
n-State Drain Current	$V_{GS} = 4.5 \text{ V}, V_{DS} = 5.0 \text{ V}$	25			Α
orward Transconductance	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 15 \text{ A}$		70		S
haracteristics					
nput Capacitance	$V_{DS} = 10 V, V_{GS} = 0 V,$		4700		pF
Output Capacitance	f = 1.0 MHz		850		pF
everse Transfer Capacitance			310		pF
Characteristics (Note 2)	,				
	$V_{DD} = 10 \text{ V}$. $I_D = 1 \text{ A}$.		20	32	ns
urn-On Rise Time	$V_{GS} = 4.5 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		27	44	ns
urn-Off Delay Time			95	133	ns
urn-Off Fall Time			35	56	ns
otal Gate Charge	V _{DS} = 10 V, I _D = 15 A,		47	66	nC
ate-Source Charge	V _{GS} = 5 V,		7		nC
ate-Drain Charge			10.5		nC
rce Diode Characteristics an	d Maximum Ratings				
				2.1	А
rain-Source Diode Forward Voltage	$V_{GS} = 0$ V. $I_{S} = 2.1$ A (Note 2)		0.65	1.2	V
	teristics (Note 2) ate Threshold Voltage ate Threshold Voltage emperature Coefficient tatic Drain-Source in-Resistance in-State Drain Current orward Transconductance Characteristics put Capacitance everse Transfer Capacitance Characteristics (Note 2) urn-On Delay Time urn-On Rise Time urn-Off Fall Time otal Gate Charge iate-Source Charge iate-Drain Charge Ce Diode Characteristics an Maximum Continuous Drain-Source	ate-Body Leakage, Reverse $V_{GS} = -12 \text{ V}, V_{DS} = 0 \text{ V}$ teristics(Note 2)ate Threshold Voltage $V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$ ate Threshold Voltage $I_D = 250 \mu\text{A}, \text{Referenced to } 25^\circ\text{C}$ emperature Coefficient $I_D = 250 \mu\text{A}, \text{Referenced to } 25^\circ\text{C}$ tatic Drain-Source $V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A},$ $T_J=125^\circ\text{C}$ $V_{GS} = 4.5 \text{ V}, V_{DS} = 5.0 \text{ V}$ orward Transconductance $V_{DS} = 5 \text{ V}, I_D = 15 \text{ A}$ that capacitance $V_{DS} = 5 \text{ V}, I_D = 15 \text{ A}$ everse Transfer Capacitance $V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHzf = 1.0 MHzurn-On Delay Time $V_{DS} = 10 \text{ V}, I_D = 1 \text{ A},$ urn-Off Delay Time $V_{DS} = 10 \text{ V}, I_D = 15 \text{ A},$ urn-Off Fall Time $V_{DS} = 10 \text{ V}, I_D = 15 \text{ A},$ urn-Off Fall Time $V_{DS} = 10 \text{ V}, I_D = 15 \text{ A},$ urn-Off Fall Time $V_{DS} = 10 \text{ V}, I_D = 15 \text{ A},$ urn-Off Fall Time $V_{DS} = 10 \text{ V}, I_D = 15 \text{ A},$ urn-Off Fall Time $V_{DS} = 10 \text{ V}, I_D = 15 \text{ A},$ urn-Off Fall Time $V_{DS} = 10 \text{ V}, I_D = 15 \text{ A},$ urn-Off Characteristics and Maximum Ratingsmate-Drain Charge $V_{GS} = 0 \text{ V}, I_S = 2.1 \text{ A},$ (Note 2) $V_{GS} = 0 \text{ V}, I_S = 2.1 \text{ A},$ (Note 2) $V_{GS} = 0 \text{ V}, I_S = 2.1 \text{ A},$	ate-Body Leakage, Reverse $V_{GS} = -12 \text{ V}, V_{DS} = 0 \text{ V}$ teristics(Note 2)ate Threshold Voltage $V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$ 0.4ate Threshold Voltage $I_D = 250 \mu\text{A}, \text{Referenced to } 25^{\circ}\text{C}$ emperature Coefficient $I_D = 250 \mu\text{A}, \text{Referenced to } 25^{\circ}\text{C}$ tatic Drain-Source $V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A}, T_J=125^{\circ}\text{C}$ un-Resistance $V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A}, T_J=125^{\circ}\text{C}$ vGS = 2.5 V, I_D = 12 Avolume to the total state to the total conductancevDS = 5 V, VDS = 5.0 V25orward Transconductance $V_{DS} = 5 \text{ V}, I_D = 15 \text{ A}$ that CapacitanceVDS = 10 V, VGS = 0 V, f = 1.0 MHzeverse Transfer CapacitanceVDS = 10 V, I_D = 1 A, VGS = 0 V, f = 1.0 MHzurn-On Delay TimeVDD = 10 V, I_D = 1 A, VGS = 4.5 V, RGEN = 6 \Omegaurn-Off Fall TimeVDS = 10 V, I_D = 15 A, VGS = 5 V, I_D = 15 A, VGS = 5 V, I_D = 15 A, VGS = 5 V, I_D = 10 V, I_D = 15 A, VGS = 5 V, I_D = 10 V, I_D =	ate-Body Leakage, Reverse $V_{GS} = -12 \text{ V}, V_{DS} = 0 \text{ V}$ teristics(Note 2)ate Threshold Voltage $V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$ 0.4 0.9 ate Threshold Voltage $I_D = 250 \mu\text{A}, \text{ Referenced to } 25^{\circ}\text{C}$ -4 emperature Coefficient $I_D = 250 \mu\text{A}, \text{ Referenced to } 25^{\circ}\text{C}$ -4 tatic Drain-Source $V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A},$ 0.006 in-Resistance $V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A},$ 0.008 in-State Drain Current $V_{GS} = 4.5 \text{ V}, V_{DS} = 5.0 \text{ V}$ 25orward Transconductance $V_{DS} = 5 \text{ V}, I_D = 15 \text{ A}$ 70Characteristicsuput Capacitance $V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V},$ 4700uput Capacitance $V_{DS} = 10 \text{ V}, I_D = 15 \text{ A}$ 20urn-On Delay Time $V_{DD} = 10 \text{ V}, I_D = 1 \text{ A},$ 20urn-Off Delay Time $V_{DS} = 10 \text{ V}, I_D = 15 \text{ A}$ 27urn-Off Fall Time 35 2727urn-Off Fall Time 35 27otal Gate Charge $V_{DS} = 10 \text{ V}, I_D = 15 \text{ A},$ 47 $V_{GS} = 5 \text{ V},$ 7 35otal Gate Charge $V_{DS} = 5 \text{ V},$ 7 ate-Drain Charge $V_{GS} = 5 \text{ V},$ 7 ate-Drain Charge $V_{OS} = 0 \text{ V}, I_S = 2.1 \text{ A},$ 0.65	ate-Body Leakage, Reverse $V_{GS} = -12 \text{ V}, V_{DS} = 0 \text{ V}$ -100 teristics (Note 2) -100 ate Threshold Voltage $V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$ 0.4 0.9 1.5 ate Threshold Voltage $I_D = 250 \mu\text{A}$, Referenced to 25°C -4 -4 emperature Coefficient $I_D = 250 \mu\text{A}$, Referenced to 25°C -4 -4 tatic Drain-Source $V_{GS} = 4.5 \text{V}, I_D = 15 \text{A}$ 0.006 0.0075 n-Resistance $V_{GS} = 4.5 \text{V}, I_D = 15 \text{A}$ 0.008 0.0100 m-State Drain Current $V_{GS} = 2.5 \text{V}, I_D = 12 \text{A}$ 0.008 0.0100 orward Transconductance $V_{DS} = 50 \text{V}$ 25 - orward Transconductance $V_{DS} = 10 \text{V}, V_{GS} = 0 \text{V},$ 4700 - turu-On Delay Time $V_{DD} = 10 \text{V}, I_D = 1 \text{A},$ 20 32 urn-On Rise Time $V_{GS} = 4.5 \text{V}, R_{GEN} = 6 \Omega$ 27 44 urn-On Rise Time $V_{S} = 10 \text{V}, I_D = 15 \text{A},$ 95 133 urn-Off Fall Time $V_{S} = 5 \text{V},$ 7 </td

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